

# **Dual Micropower Comparator**

#### **FEATURES**

- Micropower
  - 1.5 µW (1 Sample / Second)
- Power Supply Flexibility
  Single Supply + 2.8V to +16V
  Split Supply ± 2.8V to ±8V
- Guaranteed Max. Offset 0.5mV
- Guaranteed Max. Tracking Error between Input Pairs ± 0.1%
- Input Common-Mode Range to Both Supply Rails
- TTL/CMOS Compatible with ±5V or Single +5V Supply
- Input Errors are Stable with Time and Temperature

## **APPLICATIONS**

- Battery Powered Systems
- Remote Sensing
- Window Comparator
- **BANG-BANG Controllers**

## DESCRIPTION

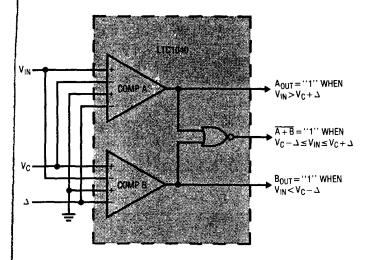
The LTC1040 is a monolithic CMOS dual comparator manufactured using Linear Technology's enhanced LTCMOS<sup>TM</sup> silicon gate process. Extremely low operating power levels are achieved by internally switching the comparator ON for short periods of time. The CMOS output logic holds the output information continuously while not consuming any power.

In addition to switching power ON, a switched output is provided to drive external loads during the comparator's active time. This allows not only low comparator power, but low total system power.

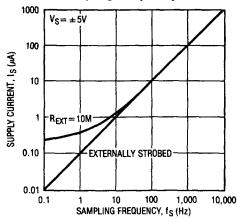
Sampling is controlled by an external strobe input or an internal oscillator. The oscillator frequency is set by an external RC network.

Each comparator has a unique input structure, giving two differential inputs. The output of the comparator will be high if the algebraic sum of the inputs is positive and low if the algebraic sum of the inputs is negative.

#### Window Comparator with Symmetric Window Limits



# Typical LTC1040 Supply Current vs Sampling Frequency



 $\mathsf{LTCMOS}^{\mathsf{TM}}$  is a trademark of Linear Technology Corporation.

## **ABSOLUTE MAXIMUM RATINGS**

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## PACKAGE/ORDER INFORMATION

STROBE 1	<u> </u>	18 V+	TEMPERATURE RANGE	ORDER PART NUMBER
ON/OFF 2  A+B 3  A <sub>OUT</sub> 4  A1+5  A1-6  A2+7  A2-8	LTC1040	17 V <sub>PP</sub> 16 OSC 15 B <sub>OUT</sub> 14 B1 + 13 B1 - 12 B2 + 11 B2 -	– 55°C to 125°C – 40°C to 85°C	LTC1040MJ LTC1040CN LTC1040CJ
GND 9		10 V -		

## **ELECTRICAL CHARACTERISTICS**

Test conditions:  $V^+ = 5V$ ,  $V^- = -5V$ ,  $T_{MIN} \le T_A \le T_{MAX}$  unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS		LTC1040M/LTC1040C			UNITS
J I IN BUL	FAIIAMETER	CONDITIONS		MIN	ТҮР	MAX	UNITO
V <sub>0S</sub>	Offset Voltage (Note 1)	Split Supplies $\pm 2.8V$ to $\pm 6V$ Single Supply (V = GND) $+ 2.8V$ to $6V$	•		± 0.3	±0.5	m∨
		Split Supplies $\pm 6V$ to $\pm 8V$ Single Supply (V = GND) $+ 6V$ to $+ 15V$	•		±1	±3	mV
	Tracking Error between Input Pairs (Notes 1 and 2)	Split Supplies $\pm 2.8V$ to $\pm 8V$ Single Supplies (V = GND) + 2.8 to + 16V	•		0.05	0.1	%
BIAS	Input Bias Current	$T_A = 25$ °C, OSC = GND			± 0.3		nA
R <sub>IN</sub>	Average Input Resistance	f <sub>S</sub> = 1kHz (Note 3)	•	20	30	<del>-</del> -	МΩ
CMR	Common-Mode Range		•	ν-		٧+	٧
PSR	Power Supply Range	Split Supplies	•	± 2.8		± 8	V
		Single Supplies (V = GND)	•	+ 2.8		+16	٧
I <sub>S(ON)</sub>	Power Supply ON Current (Note 4)	$V^+ = 5V$ , $V_{PP}$ On	•		1.2	3	mA
S(OFF)	Power Supply OFF Current (Note 4)	V <sup>+</sup> = 5V, V <sub>PP</sub> Off LTC1040C LTC1040M	•		0.001 0.001	0.5 5	μA μA
t <sub>D</sub>	Response Time (Note 5)	T <sub>A</sub> = 25°C		60	80	100	μS
	A, B, A+B and ON/OFF Outputs (Note 6)						
$V_{OH}$	Logic "1" Output Voltage	$V^{+} = 4.75V$ , $I_{OUT} = -360\mu A$	•	2.4	4.4		V
$V_{OL}$	Logic ''0'' Output Voltage	$V^+ = 4.75V$ , $I_{OUT} = 1.6mA$	•		0.25	0.4	V V
V	STROBE Input (Note 6)	V <sup>+</sup> = 5.25V			4.0		
$V_{IH}$ $V_{IL}$	Logic ''1'' Input Voltage Logic ''0'' Input Voltage	$V^{+} = 5.25V$ $V^{+} = 4.75V$	•	2.0	1.6 1.0	0.8	V V
R <sub>EXT</sub>	External Timing Resistor	Resistor Tied between V + and OSC Pin	•	100		10,000	kΩ
f <sub>S</sub>	Sampling Frequency	$T_A = 25^{\circ}C, R_{EXT} = 1M\Omega, C_{EXT} = 0.1\mu F$			5		Hz

The 
denotes the specifications which apply over the full operating temperature range.

Note 1: Applies over input voltage range limit and includes gain uncertainty.

Note 2: Tracking error =  $(V_{1N1} - V_{1N2})/V_{1N1}$ .

Note 3: RIN is guaranteed by design and is not tested.

 $R_{IN} = 1/(f_S \times 33pF)$ .

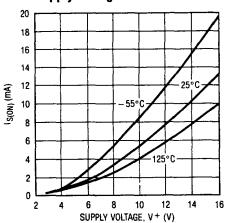
Note 4: Average supply current= $t_D \times l_S(ON) \times f_S + (1 - t_D \times f_S) \times l_S(OFF)$ .

Note 5: Response time is set by an internal oscillator and is independent of overdrive voltage.

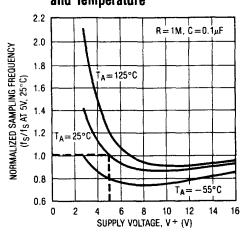
Note 6: Inputs and outputs also capable of meeting EIA/JEDEC B series CMOS specifications.

## TYPICAL PERFORMANCE CHARACTERISTICS

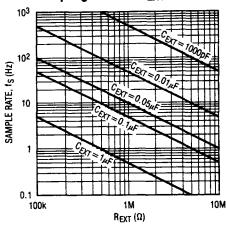
#### Peak Supply Current vs Supply Voltage



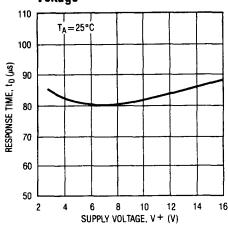
#### Normalized Sampling Frequency vs Supply Voltage and Temperature



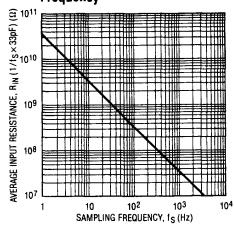
#### Sampling Rate vs R<sub>EXT</sub>, C<sub>EXT</sub>



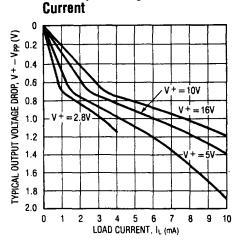
# Response Time vs Supply Voltage



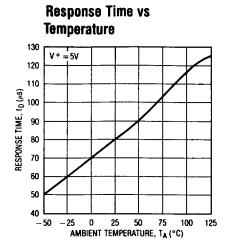
Input Resistance vs Sampling Frequency

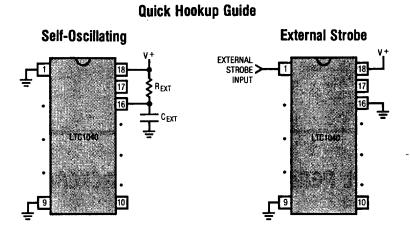


## V<sub>PP</sub> Output Voltage vs Load

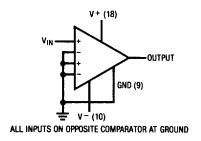


## TYPICAL PERFORMANCE CHARACTERISTICS

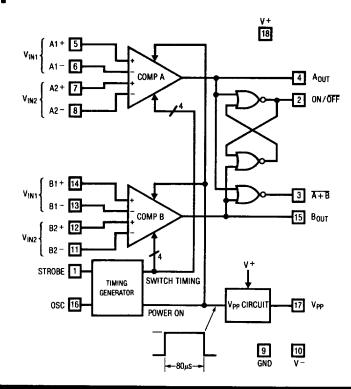




## **TEST CIRCUIT**



## **BLOCK DIAGRAM**



The LTC1040 uses sampled data techniques to achieve its unique characteristics. Some of the experience acquired using classic linear comparators does not apply to this circuit, so a brief description of internal operation is essential to proper application.

The most obvious difference between the LTC1040 and other comparators is the dual differential input structure. Functionally, when the sum of inputs is positive, the comparator output is high and when the sum of the inputs is negative, the output is low. This unique input structure is achieved with CMOS switches and a precision capacitor array. Because of the switching nature of the inputs, the concept of input current and input impedance needs to be examined.

The equivalent input circuit is shown in Figure 1. Here, the input is being driven by a resistive source,  $R_{\rm S}$ , with a bypass capacitor,  $C_{\rm S}$ . The bypass capacitor may or may not be needed, depending on the size of the source resistance and the magnitude of the input voltage,  $V_{\rm IN}$ .

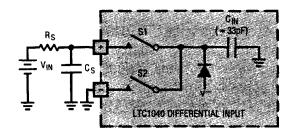


Figure 1. Equivalent Input Circuit

#### For Rs $< 10k\Omega$

Assuming C<sub>S</sub> is zero, the input capacitor, C<sub>IN</sub>, charges to V<sub>IN</sub> with a time constant of R<sub>S</sub> C<sub>IN</sub>. When R<sub>S</sub> is too large, C<sub>IN</sub> does not have a chance to fully charge during the sampling interval ( $\approx 80 \mu s$ ) and errors will result. If R<sub>S</sub> exceeds  $10 k\Omega$  a bypass capacitor is necessary to minimize errors.

#### For Rs $> 10k\Omega$

For Rs greater than  $10k\Omega$ ,  $C_{IN}$  cannot fully charge and a bypass capacitor,  $C_S$ , is needed. When switch S1 closes,

charge is shared between Cs and C<sub>IN</sub>. The change in voltage on Cs because of this charge sharing is:

$$\Delta V = V_{IN} \times \frac{C_{IN}}{C_{IN} + C_S}$$

This represents an error and can be made arbitrarily small by increasing Cs.

With the addition of  $C_S$  a second error term caused by the finite input resistance of the LTC1040 must be considered. Switches S1 and S2 alternately open and close, charging and discharging  $C_{IN}$  between  $V_{IN}$  and ground. The alternate charge and discharge of  $C_{IN}$  causes a current to flow into the positive input and out of the negative input. The magnitude of this current is:

$$l_{IN} = q \times f_S = V_{IN} C_{IN} f_S$$

where fs is the sampling frequency. Because the input current is directly proportional to input voltage, the LTC1040 can be said to have an average input resistance of:

$$R_{IN} = \frac{V_{IN}}{I_{IN}} = \frac{1}{fs C_{IN}} = \frac{1}{fs \times 33pF}$$

(see typical curve of  $R_{IN}$  vs fs). A voltage divider is set up between  $R_{S}$  and  $R_{IN}$  causing error.

The input voltage error caused by these two effects is:

$$V_{ERROR} = V_{IN} \left( \frac{C_{IN}}{C_{IN} + C_{S}} + \frac{R_{S}}{R_{S} + R_{IN}} \right).$$

$$Example: f_{S} = 10Hz, R_{S} = 1M\Omega,$$

$$C_{S} = 1\mu F, V_{IN} = 1V$$

$$V_{ERROR} = 1V \left( \frac{33 \times 10^{-12}}{1 \times 10^{-6}} + \frac{10^{6}}{10^{6} + 3 \times 10^{9}} \right)$$

$$= 33\mu V + 330\mu V = 363\mu V.$$

Notice that most of the error is caused by  $R_{IN}$ . If the sampling frequency is reduced to 1Hz, the voltage error is reduced to  $66\mu V$ .



#### **Minimizing Comparison Errors**

The two differential input voltages, V1 and V2, are converted to charge by the input capacitors C<sub>IN1</sub> and C<sub>IN2</sub> (see Figure 2). The charge is summed at the virtual ground point and if the net charge is positive, the comparator output is high and if negative, it is low. There is an optimum way to connect these inputs, in a specific application, to minimize error.

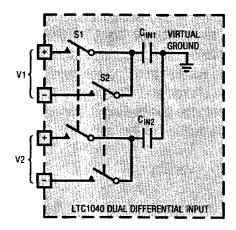


Figure 2. Dual Differential Equivalent Input Circuit

Ignoring internal offset, the LTC1040 will be at its switching point when:

$$V1 \times C_{IN1} + V2 \times C_{IN2} = 0$$
.

Optimum error will be achieved when the differential voltages, V1 and V2, are individually minimized. Figure 3 shows two ways to connect the LTC1040 to compare an input voltage,  $V_{IN}$ , to a reference voltage,  $V_{REF}$ . Using the above equation, each method will be at null when:

(a) 
$$(V_{REF} - 0V) C_{IN1} - (0V - V_{IN}) C_{IN2} = 0$$
  
or  $V_{IN} = V_{REF} (C_{IN1} / C_{IN2})$ 

(b) 
$$(V_{REF} - V_{IN}) C_{IN1} - (0V - 0V) C_{IN2} = 0$$
  
or  $V_{IN} = V_{REF}$ 

Notice that in method (a) the null point depends on the ratio of  $C_{IN1}/C_{IN2}$ , but method (b) is independent of this ratio. Also, because method (b) has zero differential input voltage, the errors due to finite input resistance are negligible. The LTC1040 has a high accuracy capacitor array and even the non-optimum connection will only result in  $\pm 0.1\%$  more error worst-case compared to the optimum connection.

#### **Tracking Error**

Tracking error is caused by the ratio error between  $C_{IN1}$  and  $C_{IN2}$  and is expressed as a percentage. For example, consider Figure 3(a) with  $V_{REF} = 1V$ . Then at null,

$$V_{IN} = V_{REF}$$
  $\frac{C_{IN1}}{C_{IN2}} = 1V \pm 1mV$ 

because C<sub>IN1</sub> is guaranteed to equal C<sub>IN2</sub> to within 0.1%.

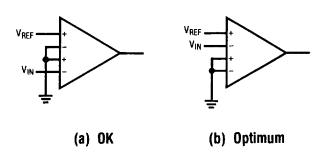


Figure 3. Two Ways to Do It

#### **Common-Mode Range**

The input switches of the LTC1040 are capable of switching to either the V $^+$  or V $^-$  supply. This means that the input common-mode range includes both supply rails. Many applications, not feasible with conventional comparators, are possible with the LTC1040. In the load current detector shown in Figure 4, a 0.1 $\Omega$  resistor is used to sense the current in the V $^+$  supply. This application requires the dual differential input and common-mode capabilities of the LTC1040.

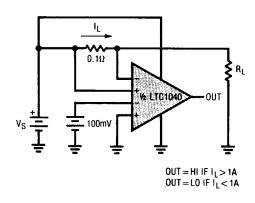


Figure 4. Load Current Detector

#### Offset Voltage Error

The errors due to offset, common-mode, power supply variation, gain and temperature are all included in the offset voltage specification. This makes it easy to compute the error when using the LTC1040.

Example: error computation for Figure 4.

Assume:  $2.8V \le V_S \le 6V$ . Then total worst-case error is:

$$I_{L(ERROR)} = \pm (100\text{mV} \times 0.001 + 0.5\text{mV}) \times \frac{1\text{A}}{100\text{mV}} = \pm 6\text{mA}$$

$$\uparrow \qquad \uparrow$$
Tracking Error  $V_{0S}$ 

$$I_{L(ERROR)}\% = \frac{6mA}{1A} \times 100 = \pm 0.6\%.$$

Note: If source resistance exceeds  $10k\Omega$ , bypass capacitors should be used and the associated errors must be included.

#### Pulsed Power (VPP) Output

It is often desirable to use comparators with resistive networks such as bridges. Because of the extremely low power consumption of the LTC1040, the power consumed by these resistive networks can far exceed that of the device itself.

At low sample rates the LTC1040 spends most of its time off. To take advantage of this, a pulsed power (V<sub>PP</sub>) output is provided. V<sub>PP</sub> is switched to V<sup>+</sup> when the comparator is on and to a high impedance (open circuit) when the comparator is off. The ON time is nominally  $80\mu s$ . Figure 5 shows the V<sub>PP</sub> output circuit.

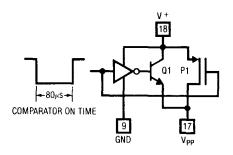


Figure 5. V<sub>PP</sub> Output Switch

The VPP output voltage is not precise (see VPP Output Voltage versus Load Current curve). There are two ways VPP can be used to power external networks without excessive errors: (1) ratiometric networks and (2) fast settling references.

In a ratiometric network (see Figure 6), the inputs are all proportional to V<sub>PP</sub>. Consequently, for small changes, the absolute value of V<sub>PP</sub> does not affect accuracy.

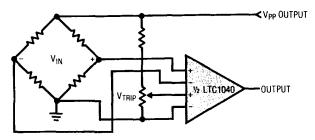


Figure 6. Ratiometric Network Driven by VPP

It is critical that the inputs to the LTC1040 completely settle within  $4\mu s$  of the start of the comparison cycle and that they do not change during the  $80\mu s$  ON time. When driving resistive networks with Vpp , capacitive loading on the network should be minimized to meet the  $4\mu s$  settling time requirement. It is not recommended that Vpp be used to drive networks with source impedances, as seen by the inputs, of greater than  $10k\Omega$ .

In applications where an absolute reference is required, the Vpp output can be used to drive a fast settling reference. The LT1009 2.5V reference, ideal in this application, settles in approximately  $2\mu s$  (see Figure 7). The current through R1 must be large enough to supply the LT1009 minimum bias current (  $\approx$  1mA) and the load current, I<sub>1</sub>.

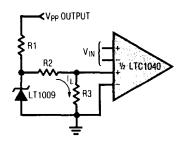


Figure 7. Driving Reference with VPP Output

#### **Output Logic**

In addition to the normal outputs (AOUT and BOUT), two additional outputs, A+B and ON/OFF, are provided (see Figure 8 and Table I). All logic is powered from  $V^+$  and ground, thus input and output logic levels are independent of the  $V^-$  supply. The LTC1040 is directly compatible with CMOS logic and is TTL compatible for  $4.75V \le V^+ \le 5.25V$ . No external pull-up resistors are required.

Table I. Output Logic Truth Table

<b>SAINPUTS</b>	$\Sigma B$ INPUTS	A <sub>out</sub>	Bout	$\overline{A + B}$	ON/OFF
+	+	Н	Н	L	L
+	_	Н	L	L	L
_	+	L	Н	L	Н
_	_	Ł	L	Н	1*

<sup>\*</sup>I = indeterminate. When both A and B outputs are low, the ON  $/ \overline{OFF}$  output remains in the state it was in prior to entering  $A_{OUT} = B_{OUT} = L$ .

#### **Using External Strobe**

A positive pulse on the strobe input, with the OSC input tied to ground, will initiate a comparison cycle. The STROBE input is edge-sensitive and pulse widths of 50ns will typically trigger the device.

COMPARATOR A OUTPUT C Q AOUT (4)

COMPARATOR B OUTPUT C Q BOUT (15)

Figure 8. LTC1040 Logic Diagram

Because of the sampling nature of the LTC1040, some sensitivity exists between the offset voltage and the falling edge of the input strobe. When the falling edge of the strobe signal falls within the comparator's active time ( $80\mu s$  after rising edge), offset changes of as much as 2mV can occur. To eliminate this problem, make sure the strobe pulse width is greater than the response time, t<sub>D</sub>.

#### **Using Internal Strobe**

An internal oscillator allows the LTC1040 to strobe itself. The frequency of oscillation, and hence sampling rate, is set by an external RC network (see typical curve of frequency versus Rext, Cext).

For self-oscillation, the STROBE pin must be tied to ground. The external RC network is connected as shown in Figure 9.

To assure oscillation,  $R_{EXT}$  must be between 100k and 10M. There is no limit to the size of  $C_{EXT}$ .

REXT is very important in determining the power consumption. The average voltage at the oscillator pin is approximately  $V^+/2$ . The power consumed by REXT is then:  $P_{REXT} = (V^+/2)^2/R_{EXT}$ .

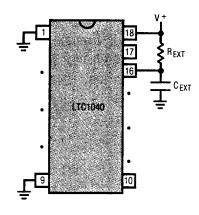


Figure 9. External RC Connection

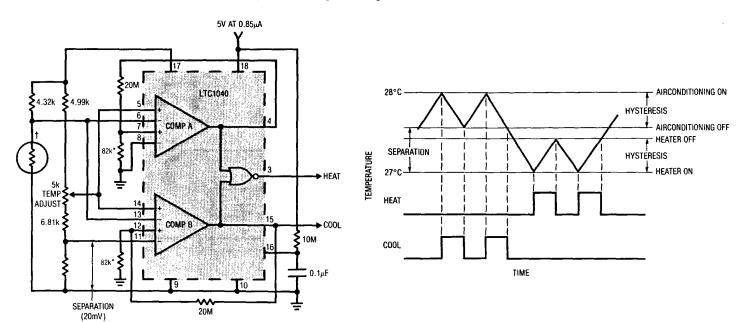
Example:  $R_{EXT} = 1M$ ,  $V^+ = 5V$ ,  $P_{REXT} = (2.5)^2 / 10^6 = 6.25 \times 10^{-6} W$ .

This is about four times the power consumed by the LTC1040 at  $V^+ = 5V$  and  $f_S = 1$  sample/second. Where

power is a premium  $R_{EXT}$  should be made as large as possible. Note that the power consumed by  $R_{EXT}$  is *not* a function of fs or  $C_{EXT}$ .

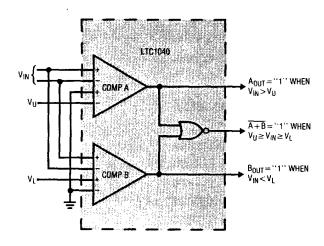
## TYPICAL APPLICATIONS

#### **Complete Heating/Cooling Automatic Thermostat**



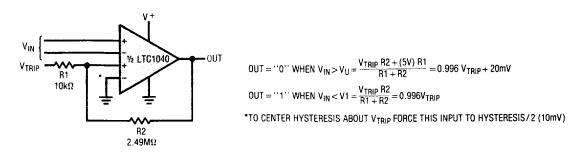
- THERMISTOR #44007
- YELLOW SPRINGS INSTRUMENT CO., INC.
- \*HYSTERESIS =  $5V \times \frac{82k}{20M} = 20mV$

#### Window Comparator with Independent Window Limits and Fully Floating Differential Input

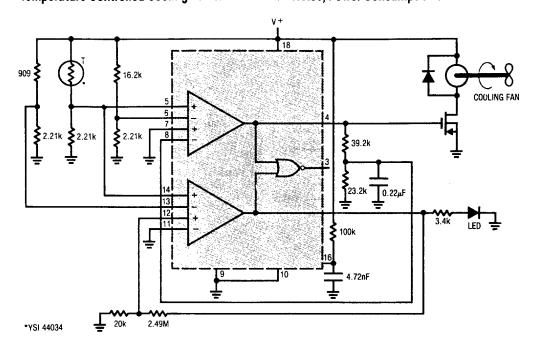


### TYPICAL APPLICATIONS

### Hysteresis Comparator with Fully Floating Differential Input



#### Temperature Controlled Cooling Fan to Reduce Fan Noise, Power Consumption and Wear



#### The LTC1040 as a Linear Amplifier

With a simple RC filter the LTC1040 can be made to function as a linear amplifier. By filtering the logic output and feeding it back to the negative input, the loop forces the output duty cycle  $[t_{ON}/(t_{ON}+t_{OFF})]$  so that  $V_{OUT}$  equals  $V_{IN}$  (Figure 10).

The RC time constant is set to keep the ripple on the output small. The maximum output ripple is:  $\Delta V = V^+ / f_S RC$  and should be set to 0.5mV to 1mV for best results. Notice that the higher the sampling frequency,  $f_S$ , the lower RC can be. This is important because the RC filter also sets the loop response. A convenient way to keep  $f_S$  as high as possible under all conditions is to connect a 100k resistor to pin 16 (OSC) with no capacitance to ground.

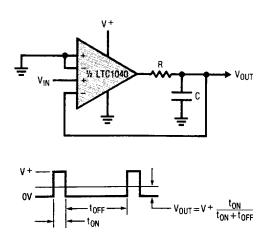
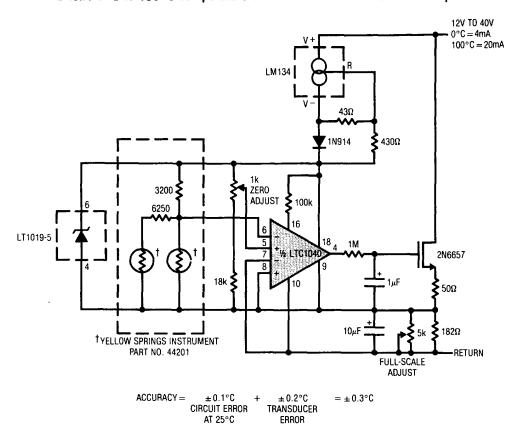


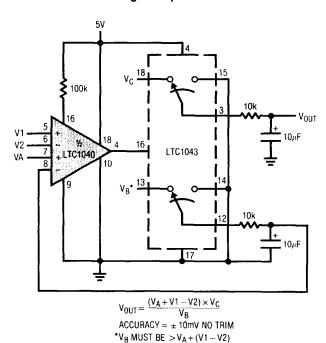
Figure 10. The LTC1040 as a Linear Amplifier

## TYPICAL APPLICATIONS

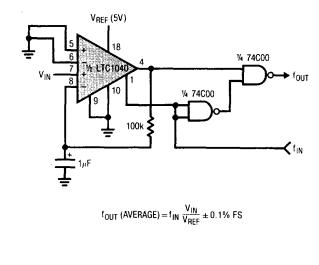
#### 2-Wire 0°C to 100°C Temperature Transducer with 4mA to 20mA Output



#### Analog Multiplier/Divider

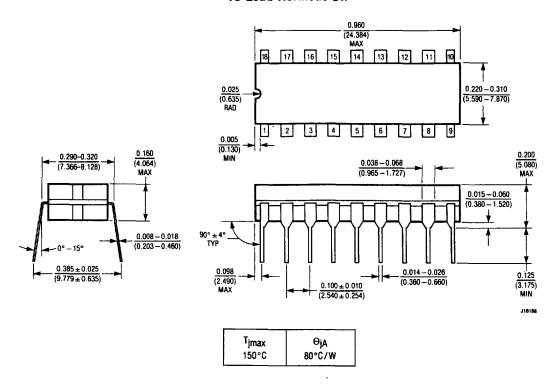


#### Single +5V Voltage-to-Frequency Converter



# PACKAGE DESCRIPTION Dimensions in inches (millimeters) unless otherwise noted.

J Package 18 Lead Hermetic DIP



N Package 18 Lead Plastic DIP

